



Dual N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)	
40	0.060 at V _{GS} = 10 V	5.0	5.6	
	0.070 at V _{GS} = 4.5 V	4.7	5.6	

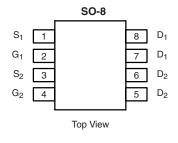
FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested

Pb-free ROHS COMPLIANT HALOGEN FREE Available

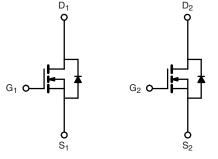
APPLICATIONS

CCFL Inverter



Ordering Information: Si4908DY-T1-E3 (Lead (Pb)-free)

Si4908DY-T1-GE3 (Lead (Pb)-free and Halogen-free)



N-Channel MOSFET

N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	40	V		
Gate-Source Voltage	V_{GS}	± 16	V		
	T _C = 25 °C		5		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	4.7		
Continuous Diam Current (1) = 100 C)	T _A = 25 °C	υ [4.1 ^{b, c}		
	T _A = 70 °C		3.3 ^{b, c}		
Pulsed Drain Current (10 µs Pulse Width)		I _{DM}	20	A	
Source-Drain Current Diode Current	T _C = 25 °C	I _S	2.3	^	
Source-Drain Current Diode Current	T _A = 25 °C	'S	1.5 ^{b, c}		
Pulsed Source-Drain Current		I _{SM}	20		
Single Pulse Avalanche Current L = 0.1 m		I _{AS}	7		
Single Pulse Avalanche Energy	L=0.11IIII	E _{AS}	2.5		
	T _C = 25 °C		2.75		
Maximum Power Dissipation	T _C = 70 °C	P_{D}	1.75	w	
	T _A = 25 °C	' b	1.85 ^{b, c}	VV	
	T _A = 70 °C		1.18 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Тур.	Max.	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	57	67.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady-State	R _{thJF}	35	45] 5/**	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 120 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Typ. ^a	Max.	Unit	
Static				•			
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$\Delta V_{DS}/T_{J}$ $I_{D} = 250 \mu A$		40		m)//°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = 230 μΑ		- 4.6		mV/°C	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.8		2.2	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 16 \text{ V}$			100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V			1	μА	
		$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	20			Α	
	Б	V _{GS} = 10 V, I _D = 4.1 A		0.048	0.060	Ω	
Drain-Source On-State Resistance ^b	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 3.8 \text{ A}$		0.056	0.070		
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 4.1 A		15		S	
Dynamic ^a		1					
Input Capacitance	C _{iss}			355			
Output Capacitance	C _{oss}	V _{DS} = 20 V, V _{GS} = 0 V, I _D = 1 MHz		50		pF	
Reverse Transfer Capacitance	C _{rss}			29		1	
·		$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		8	12	nC	
Total Gate Charge	Q _g	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$		3.7	6		
Gate-Source Charge	Q _{gs}			1.1			
Gate-Drain Charge	Q _{gd}			1.4			
Gate Resistance	R_{g}	f = 1 MHz		3.4	5.2	Ω	
Turn-On Delay Time	t _{d(on)}			8	13		
Rise Time	t _r	$V_{DD} = 20 \text{ V}, R_L = 4 \Omega$		20	30	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1 \text{ A, V}_{GEN} = 10 \text{ V, R}_g = 1 \Omega$		23	35		
Fall Time	t _f			27	42		
Turn-On Delay Time	t _{d(on)}			74	110		
Rise Time	t _r	V_{DD} = 20 V, R_L =4 Ω		95	145		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		31	48		
Fall Time	t _f			33	50		
Drain-Source Body Diode Characterist	ics			l	L		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.3	_	
Pulse Diode Forward Current ^a	I _{SM}				20	A	
Body Diode Voltage	V_{SD}	I _S = 1.5 A		0.8	1.2	٧	
Body Diode Reverse Recovery Time	t _{rr}			26	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 2 A, dl/dt = 100 A/μs, T _J = 25 °C		26	40	nC	
Reverse Recovery Fall Time	t _a			13		ns	
Reverse Recovery Rise Time	t _b			13			

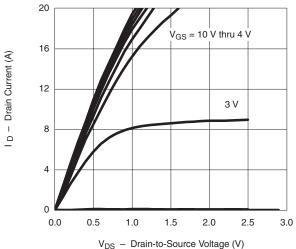
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

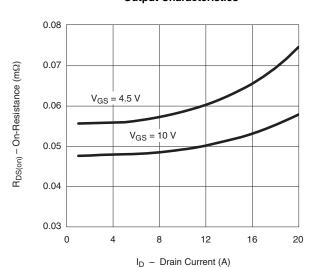




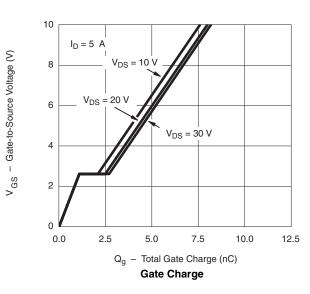
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

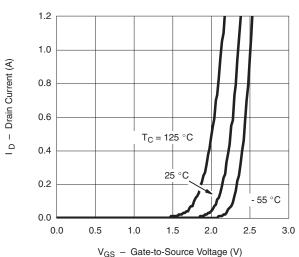


Output Characteristics

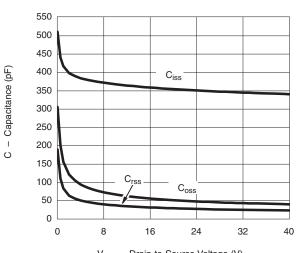


On-Resistance vs. Drain Current and Gate Voltage

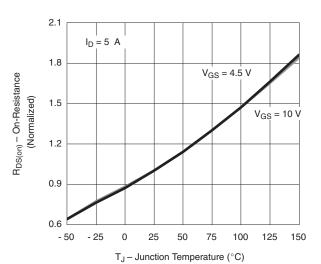




Transfer Characteristics



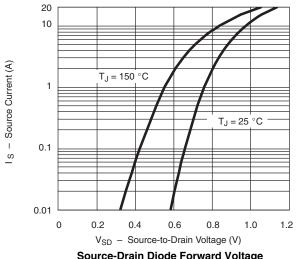
V_{DS} - Drain-to-Source Voltage (V) **Capacitance**

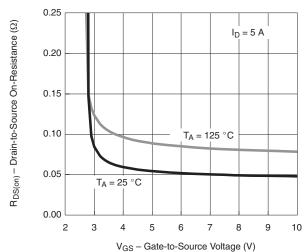


On-Resistance vs. Junction Temperature

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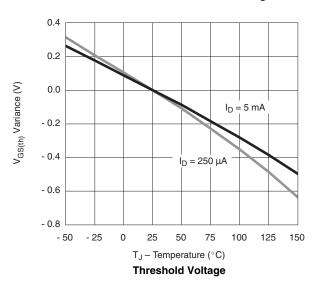
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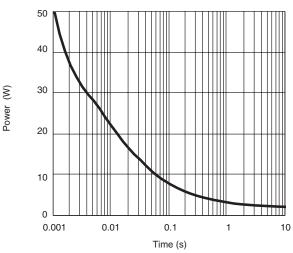




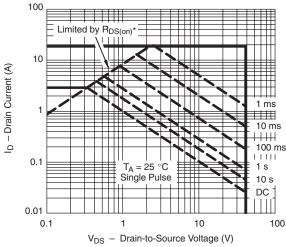
Source-Drain Diode Forward Voltage







Single Pulse Power, Junction-to-Ambient

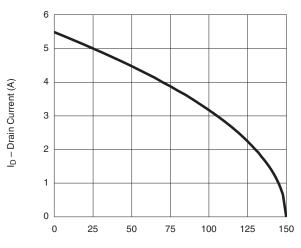


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

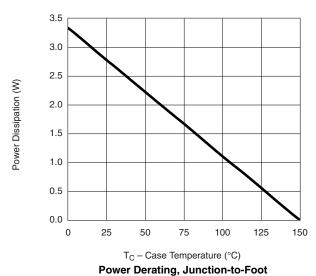


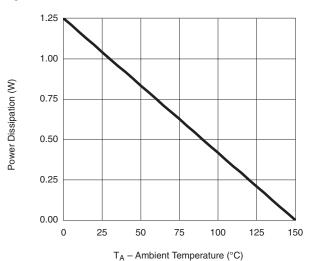
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





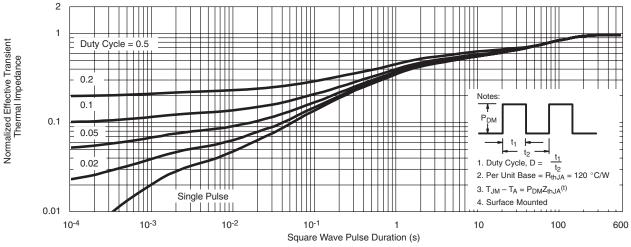
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

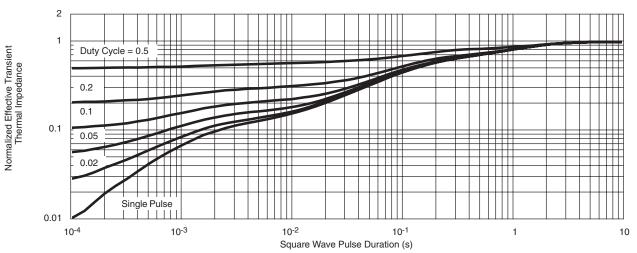
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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